

Notice of References Cited

Application/Control No.

10/573,824

Applicant(s)/Patent Under
Reexamination
HARASHINA, HATSUHIKO

Examiner

Wayne K. Leung

Art Unit

4171

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,947,367 A	03-1976	Foelsch et al.	508/510
*	B	US-4,386,178 A	05-1983	Schuetz et al.	524/100
*	C	US-4,929,712 A	05-1990	Sugiyama et al.	528/230
*	D	US-2002/0032259 A1	03-2002	Harvey et al.	524/283
*	E	US-2003/0162912 A1	08-2003	Disch et al.	525/539
*	F	US-2003/0195280 A1	10-2003	Disch et al.	524/100
*	G	US-6,753,363 B1	06-2004	Harashina, Hatsuhiro	524/99
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 2001-05888	01-2001	JP	Harashina, Hatsuhiro	C08L 59/00
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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